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DOCUMENT NUMBER DATE NAME CLASS SUBCLASS FILING DATE	Form PTO-1449 U.S. DEPARTMENT OF COMMERCE (REV. 7-80)PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)			Atty. Docket N . BUR920010120US2 (: Applicant David M. Fried, et al. Filing Date Herewith	Serial N . Unassigned Group Unassigned				
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